

CDx4HC(T)259 高速 SMOS 逻辑 8 位可寻址锁存器

1 特性

- 缓冲输入和输出
- 四个工作模式
- 当 $V_{CC} = 5V$ 、 $C_L = 15pF$ 、 $T_A = 25^\circ C$ 时的传播延迟典型值
- 扇出 (在温度范围内)
 - 标准输出: 10 个 LSTTL 负载
 - 总线驱动器输出: 15 个 LSTTL 负载
- 宽工作温度范围: $-55^\circ C$ 至 $125^\circ C$
- 平衡的传播延迟及转换时间
- 与 LSTTL 逻辑 IC 相比, 可显著降低功耗
- HC 类型
 - 工作电压为 2 V 至 6 V
 - 高抗噪性: 当 $V_{CC} = 5 V$ 时, $N_{IL} = 30\%$, $N_{IH} = V_{CC}$ 的 30%
- HCT 类型
 - 工作电压为 4.5 V 至 5.5 V
 - 直接 LSTTL 输入逻辑兼容性, $V_{IL} = 0.8V$ (最大值), $V_{IH} = 2V$ (最小值)
 - CMOS 输入兼容性, 当电压为 V_{OL} 、 V_{OH} 时, $I_I \leq 1\mu A$

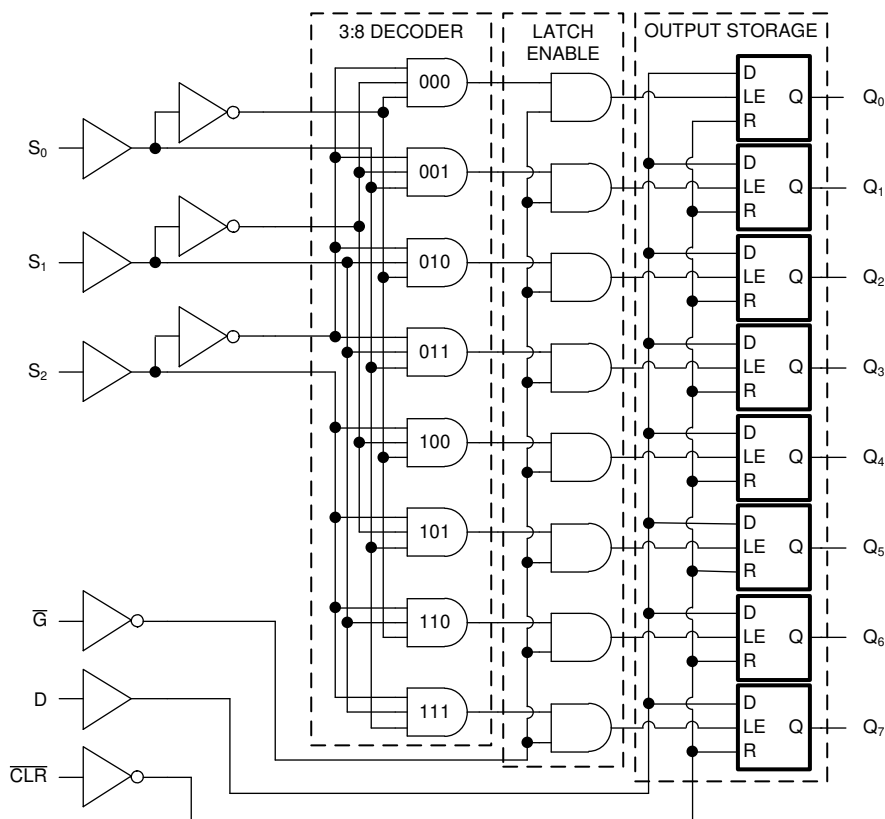
2 说明

CDx4HC(T)259 是具有三个有效工作模式 (可寻址锁存器、存储器和 8 线解码器) 和一个复位模式的 8 位可寻址锁存器。

器件信息

器件型号	封装 ⁽¹⁾	封装尺寸 (标称值)
CD54HC259F3A	陶瓷双列直插封装 (CDIP) (16)	21.34mm × 6.92mm
CD54HCT259F3A	陶瓷双列直插封装 (CDIP) (16)	21.34mm × 6.92mm
CD74HC259E	PDIP (16)	19.31mm × 6.35mm
CD74HCT259E	PDIP (16)	19.31mm × 6.35mm
CD74HC259M	SOIC (16)	9.90mm × 3.90mm
CD74HCT259M	SOIC (16)	9.90mm × 3.90mm

(1) 如需了解所有封装, 请参阅数据表末尾的可订购产品附录。



功能框图



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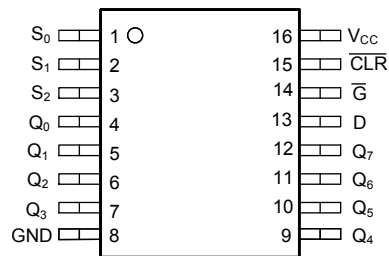
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3 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision C (October 2003) to Revision D (November 2021)	Page
• 更新了整个文档中的编号、格式、表格、图和交叉参考，以反映现代数据表标准.....	1
• Updated pin names to match current TI naming conventions. A ₀ is now S ₀ , A ₁ is now S ₁ , A ₂ is now S ₂	3

4 Pin Configuration and Functions



**J, D or PW Package
16-Pin CDIP, SOIC or TSSOP
Top View**

5 Specifications

5.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V_{CC}	Supply voltage		-0.5	7	V
I_{IK}	Input clamp diode current	For $V_I < -0.5V$ or $V_I > V_{CC} + 0.5V$		± 20	mA
I_{OK}	Output clamp diode current	For $V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$		± 20	mA
I_O	Drain current, per output	For $-0.5V < V_O < V_{CC} + 0.5V$		± 25	mA
I_O	Output source or sink current per output pin	For $V_O > -0.5V$ or $V_O < V_{CC} + 0.5V$		± 25	mA
	Continuous current through V_{CC} or GND			± 50	mA
T_J	Junction temperature			150	°C
T_{stg}	Storage temperature		-65	150	°C
	Lead temperature (Soldering 10s) (SOIC - lead tips only)			300	°C

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 Recommended Operating Conditions

			MIN	MAX	UNIT
V_{CC}	Supply voltage range	HC Types	2	6	V
		HCT Types	4.5	5.5	
V_I	Input voltage		0	V_{CC}	V
V_O	Output voltage		0	V_{CC}	V
t_t	Input rise and fall time	$V_{CC} = 2V$		1000	ns
		$V_{CC} = 4.5V$		500	
		$V_{CC} = 6V$		400	
T_A	Temperature range		-55	125	°C

5.3 Thermal Information

THERMAL METRIC		CD74HC259, CD74HCT259		UNIT
		N (PDIP)	D (SOIC)	
		16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾	67	73	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

5.4 Electrical Characteristics

PARAMETER		TEST CONDITIONS	V _{CC} (V)	25°C			-40°C to 85°C		-55°C to 125°C		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
HC TYPES											
V _{IH}	High-level input voltage		2	1.5			1.5		1.5		V
			4.5	3.15			3.15		3.15		V
			6	4.2			4.2		4.2		V
V _{IL}	Low-level input voltage		2	0.5			0.5		0.5		V
			4.5	1.35			1.35		1.35		V
			6	1.8			1.8		1.8		V
V _{OH}	High-level output voltage	I _{OH} = - 20 μA	2	1.9			1.9		1.9		V
		I _{OH} = - 20 μA	4.5	4.4			4.4		4.4		V
		I _{OH} = - 20 μA	6	5.9			5.9		5.9		V
	High-level output voltage	I _{OH} = - 4 mA	4.5	3.98			3.84		3.7		V
		I _{OH} = - 5.2 mA	6	5.48			5.34		5.2		V
V _{OL}	Low-level output voltage	I _{OL} = 20 μA	2	0.1			0.1		0.1		V
		I _{OL} = 20 μA	4.5	0.1			0.1		0.1		V
		I _{OL} = 20 μA	6	0.1			0.1		0.1		V
	Low-level output voltage	I _{OL} = 4 mA	4.5	0.26			0.33		0.4		V
		I _{OL} = 5.2 mA	6	0.26			0.33		0.4		V
I _I	Input leakage current	V _I = V _{CC} or GND	6	±0.1			±1		±1		μA
I _{CC}	Supply current	V _I = V _{CC} or GND	6	8			80		160		μA
HCT TYPES											
V _{IH}	High-level input voltage		4.5 to 5.5	2			2		2		V
V _{IL}	Low-level input voltage		4.5 to 5.5	0.8			0.8		0.8		V
V _{OH}	High-level output voltage	V _{OH} = - 20 μA	4.5	4.4			4.4		4.4		V
	High-level output voltage	V _{OH} = - 4 mA	4.5	3.98			3.84		3.7		V
V _{OL}	Low-level output voltage	V _{OL} = 20 μA	4.5	0.1			0.1		0.1		V
	Low-level output voltage	V _{OL} = 4 mA	4.5	0.26			0.33		0.4		V
I _I	Input leakage current	V _I = V _{CC} or GND	5.5	±0.1			±1		±1		μA
I _{CC}	Supply current	V _I = V _{CC} or GND	5.5	8			80		160		μA
ΔI _{CC} (1)	Additional supply current per input pin	One of A0 - A2 and LE inputs held at V _{CC} - 2.1	4.5 to 5.5	100 540			675		735		μA
		D input held at V _{CC} - 2.1	4.5 to 5.5	100 432			540		588		
		MR input held at V _{CC} - 2.1	4.5 to 5.5	100 270			337.5		367.5		

(1) V_I = V_{IH} or V_{IL}, unless otherwise noted.

5.5 Prerequisite for Switching Characteristics

PARAMETER		V _{CC} (V)	25°C			-40°C to 85°C			-55°C to 125°C			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
HC TYPES												
t _{WL}	Pulse Width $\overline{G}$	2	70			90			105			ns
		4.5	14			18			21			
		5	12			15			18			
t _{WL}	$\overline{CLR}$	2	70			90			105			ns
		4.5	14			18			21			
		6	12			15			18			
t _{SU}	Setup time D to $\overline{G}$ S to $\overline{G}$	2	80			100			120			ns
		4.5	16			20			24			
		6	14			17			20			
t _H	Hold time D to $\overline{G}$ S to $\overline{G}$	2	0			0			0			ns
		4.5	0			0			0			
		6	0			0			0			
HCT TYPES												
t _{WL}	Pulse width $\overline{G}$ $\overline{CLR}$	4.5	18			23			27			ns
t _{SU}	Setup Time D to $\overline{G}$ S to $\overline{G}$	4.5	17			21			26			ns
t _H	Hold Time D to $\overline{G}$ S to $\overline{G}$	4.5	0			0			0			pF

5.6 Switching Characteristics⁽²⁾

$C_L = 50\text{pF}$, Input $t_t = 6\text{ns}$

PARAMETER		V _{CC} (V)	25°C			-40°C to 85°C		-55°C to 125°C		UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
HC TYPES											
t _{pd}	D to Q	2	185			230		280		ns	
		4.5	15 ⁽¹⁾			46		56			
		6	31			39		48			
	$\overline{G}$ to Q	2	170			215		255		ns	
		4.5	14 ⁽¹⁾			43		51			
		6	29			37		43			
	S to Q	2	185			230		280		ns	
		4.5	15 ⁽¹⁾			46		56			
		6	31			39		48			
	$\overline{CLR}$ to Q	2	155			195		235		ns	
		4.5	13 ⁽¹⁾			39		47			
		6	26			33		40			
t _t	Output transition time	2	75			95		110		ns	
		4.5	15			19		22			
		6	13			16		19			
C _{pd}	Power dissipation Capacitance ⁽¹⁾	5	21 ⁽¹⁾							pF	
C _i	Input capacitance		10			10		10		pF	
HCT TYPES											
t _{pd}	D to Q	4.5	16 ⁽¹⁾			39		49		59	ns
	$\overline{G}$ to Q	4.5	16 ⁽¹⁾			38		48		57	ns
	S to Q	4.5	17 ⁽¹⁾			41		51		61	ns
	$\overline{CLR}$ to Q	4.5	16 ⁽¹⁾			39		49		59	pF
C _{pd}	Power dissipation Capacitance ⁽¹⁾	5	22 ⁽¹⁾								pF
C _i	Input Capacitance		10			10		10		10	pF
t _t	Output transition time	4.5	15			19		22		ns	

(1) $C_L = 15\text{pF}$ and $V_{CC} = 5\text{V}$.

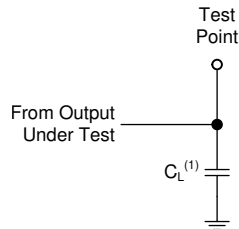
(2) For details on CMOS power calculation see, [SCAA053B](#).

6 Parameter Measurement Information

Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1 \text{ MHz}$, $Z_O = 50 \Omega$, $t_f < 6 \text{ ns}$.

For clock inputs, $f_{\max}$ is measured when the input duty cycle is 50%.

The outputs are measured one at a time with one input transition per measurement.



(1) C_L includes probe and test-fixture capacitance.

图 6-1. Load Circuit for Push-Pull Outputs

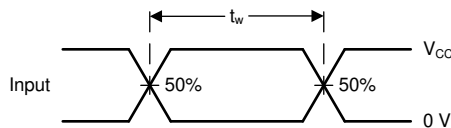


图 6-2. Voltage Waveforms, Standard CMOS Inputs Pulse Duration

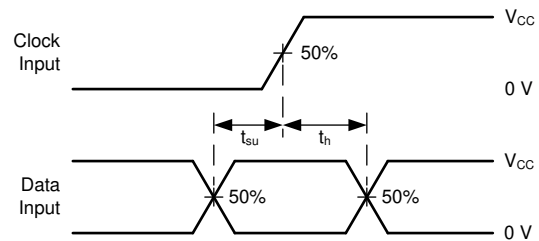
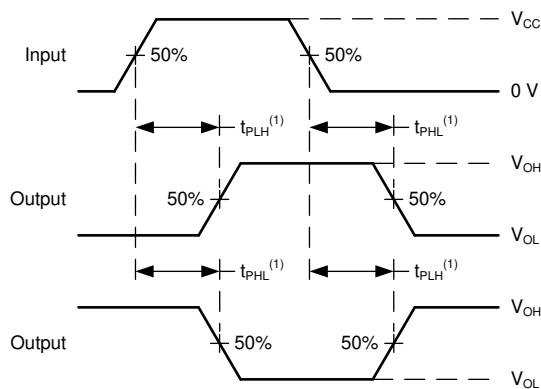
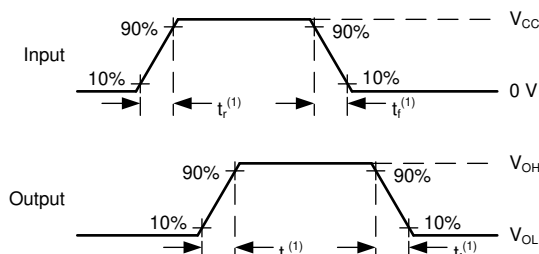


图 6-3. Voltage Waveforms, Standard CMOS Inputs Setup and Hold Times



(1) The greater between t_{PLH} and t_{PHL} is the same as t_{pd} .

图 6-4. Voltage Waveforms, Propagation Delays for Standard CMOS Inputs



(1) The greater between t_r and t_f is the same as t_t .

图 6-5. Voltage Waveforms, Input and Output Transition Times for Standard CMOS Inputs

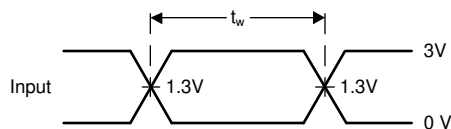


图 6-6. Voltage Waveforms, TTL-Compatible CMOS Inputs Pulse Duration

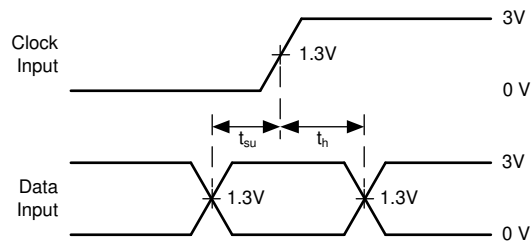
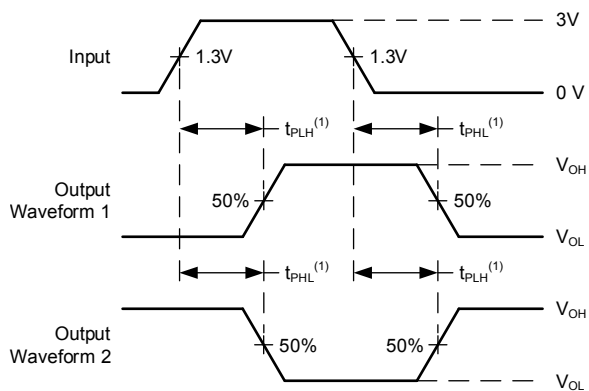


图 6-7. Voltage Waveforms, TTL-Compatible CMOS Inputs Setup and Hold Times



(1) The greater between t_{PLH} and t_{PHL} is the same as t_{pd} .

图 6-8. Voltage Waveforms, Propagation Delays for TTL-Compatible Inputs

7 Detailed Description

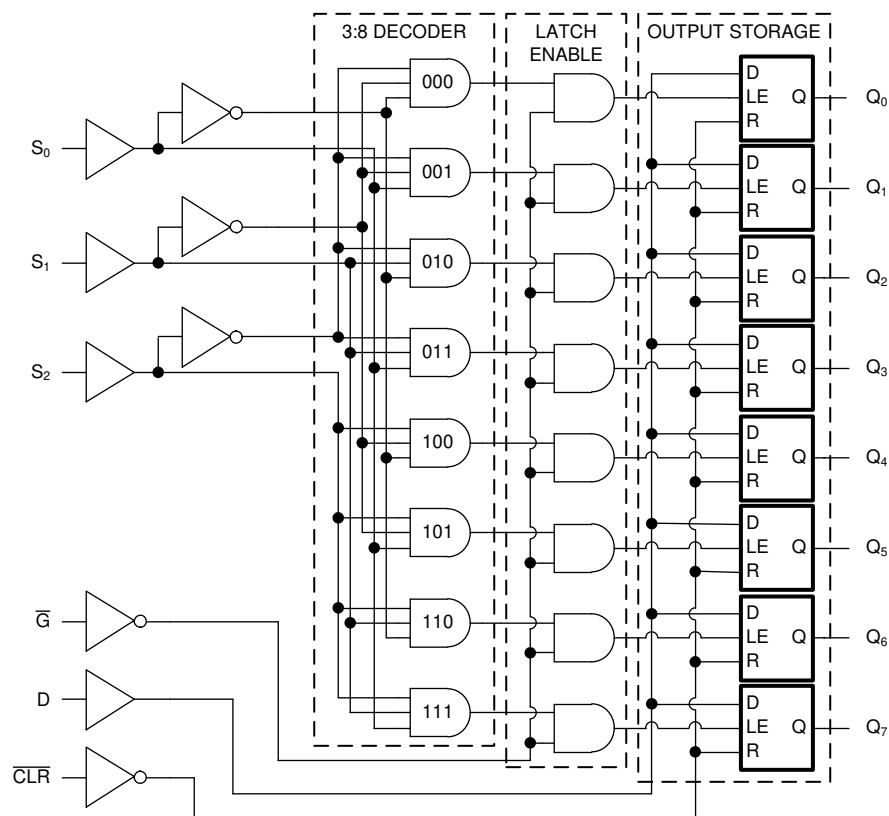
7.1 Overview

The CDx4HC(T)259 8-bit addressable latches are designed for general-purpose storage applications in digital systems. Specific uses include working registers, serial-holding registers, and active-high decoders or demultiplexers. They are multifunctional devices capable of storing single-line data in eight addressable latches and being a 1-of-8 decoder or demultiplexer with active-high outputs.

Four distinct modes of operation are selectable by controlling the clear ($\overline{\text{CLR}}$) and enable ($\overline{\text{G}}$) inputs:

- Addressable-latch mode: $\overline{\text{CLR}} = \text{HIGH}$; $\overline{\text{G}} = \text{LOW}$
 - Data at the data-in terminal is written into the addressed latch
 - The addressed latch follows the data input, with all unaddressed latches remaining in their previous states
- Memory mode: $\overline{\text{CLR}} = \text{HIGH}$; $\overline{\text{G}} = \text{HIGH}$
 - All latches remain in their previous states and are unaffected by the data or address inputs
 - To eliminate the possibility of entering erroneous data in the latches, $\overline{\text{G}}$ should be held high (inactive) while the address lines are changing
- 1-of-8 decoding or demultiplexing mode: $\overline{\text{CLR}} = \text{LOW}$; $\overline{\text{G}} = \text{LOW}$
 - The addressed output follows the level of the D input with all other outputs low
- Clear mode: $\overline{\text{CLR}} = \text{LOW}$; $\overline{\text{G}} = \text{HIGH}$
 - All outputs are low and unaffected by the address and data inputs

7.2 Functional Block Diagram



7.3 Device Functional Modes

The [Function Table](#) and [Latch Selection Table](#) below list the functional modes of the CDx4HC(T)259.

表 7-1. Function Table

INPUTS ⁽¹⁾		OUTPUT OF ADDRESSED LATCH ⁽²⁾	EACH OTHER OUTPUT ⁽²⁾	FUNCTION
CLR	G			
H	L	D	Q _{IO}	Addressable latch
H	H	Q _{IO}	Q _{IO}	Memory
L	L	D	L	8-line demultiplexer
L	H	L	L	Clear

(1) H = High voltage level, L = Low voltage level

(2) Q_{IO} = Previous output state of selected latch, D = Data input logic value

表 7-2. Latch Selection Table

SELECT INPUTS ⁽¹⁾			LATCH ADDRESSED
S2	S1	S0	
L	L	L	0
L	L	H	1
L	H	L	2
L	H	H	3
H	L	L	4
H	L	H	5
H	H	L	6
H	H	H	7

(1) H = High Voltage Level, L = Low Voltage Level

8 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- μ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

9 Layout

9.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC} , whichever makes more sense for the logic function or is more convenient.

10 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

10.1 Documentation Support

10.1.1 Related Documentation

10.2 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://www.ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

10.3 支持资源

[TI E2E™ 支持论坛](#) 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

10.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.6 术语表

[TI 术语表](#) 本术语表列出并解释了术语、首字母缩略词和定义。

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-8985201EA	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8985201EA CD54HCT259F3A
CD54HC259F3A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8551901EA CD54HC259F3A
CD54HC259F3A.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8551901EA CD54HC259F3A
CD54HCT259F3A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8985201EA CD54HCT259F3A
CD54HCT259F3A.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8985201EA CD54HCT259F3A
CD74HC259E	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HC259E
CD74HC259E.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HC259E
CD74HC259M	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	HC259M
CD74HC259M96	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-55 to 125	HC259M
CD74HC259M96.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC259M
CD74HC259M96G4	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC259M
CD74HC259M96G4.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC259M
CD74HC259MT	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	HC259M
CD74HCT259E	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HCT259E
CD74HCT259E.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HCT259E
CD74HCT259EE4	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HCT259E
CD74HCT259M	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	HCT259M
CD74HCT259M96	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259M96.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259M96G4	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259M96G4.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259MT	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	HCT259M

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

(2) Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) RoHS values: Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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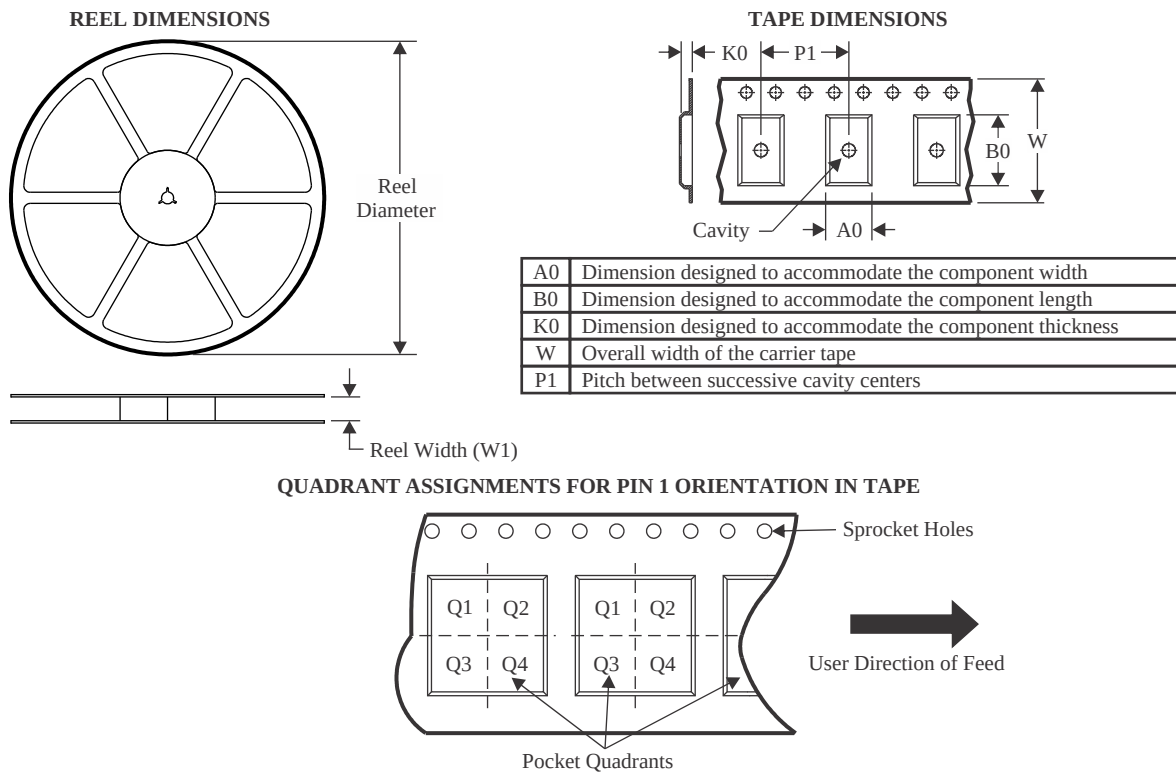
OTHER QUALIFIED VERSIONS OF CD54HC259, CD54HCT259, CD74HC259, CD74HCT259 :

- Catalog : [CD74HC259](#), [CD74HCT259](#)
- Military : [CD54HC259](#), [CD54HCT259](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

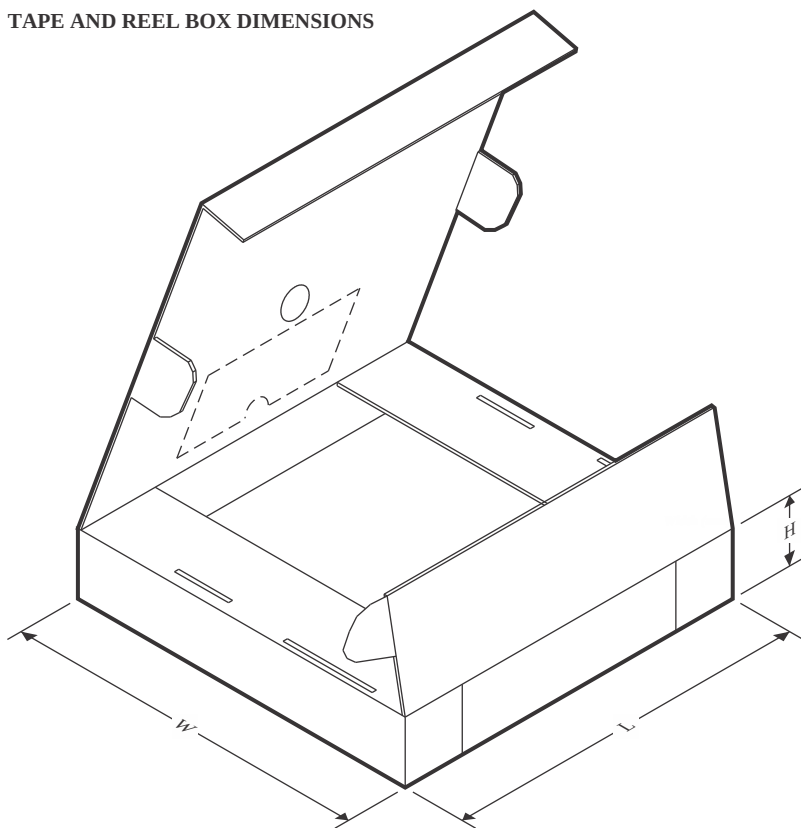
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC259M96G4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HCT259M96G4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC259M96G4	SOIC	D	16	2500	353.0	353.0	32.0
CD74HCT259M96G4	SOIC	D	16	2500	353.0	353.0	32.0

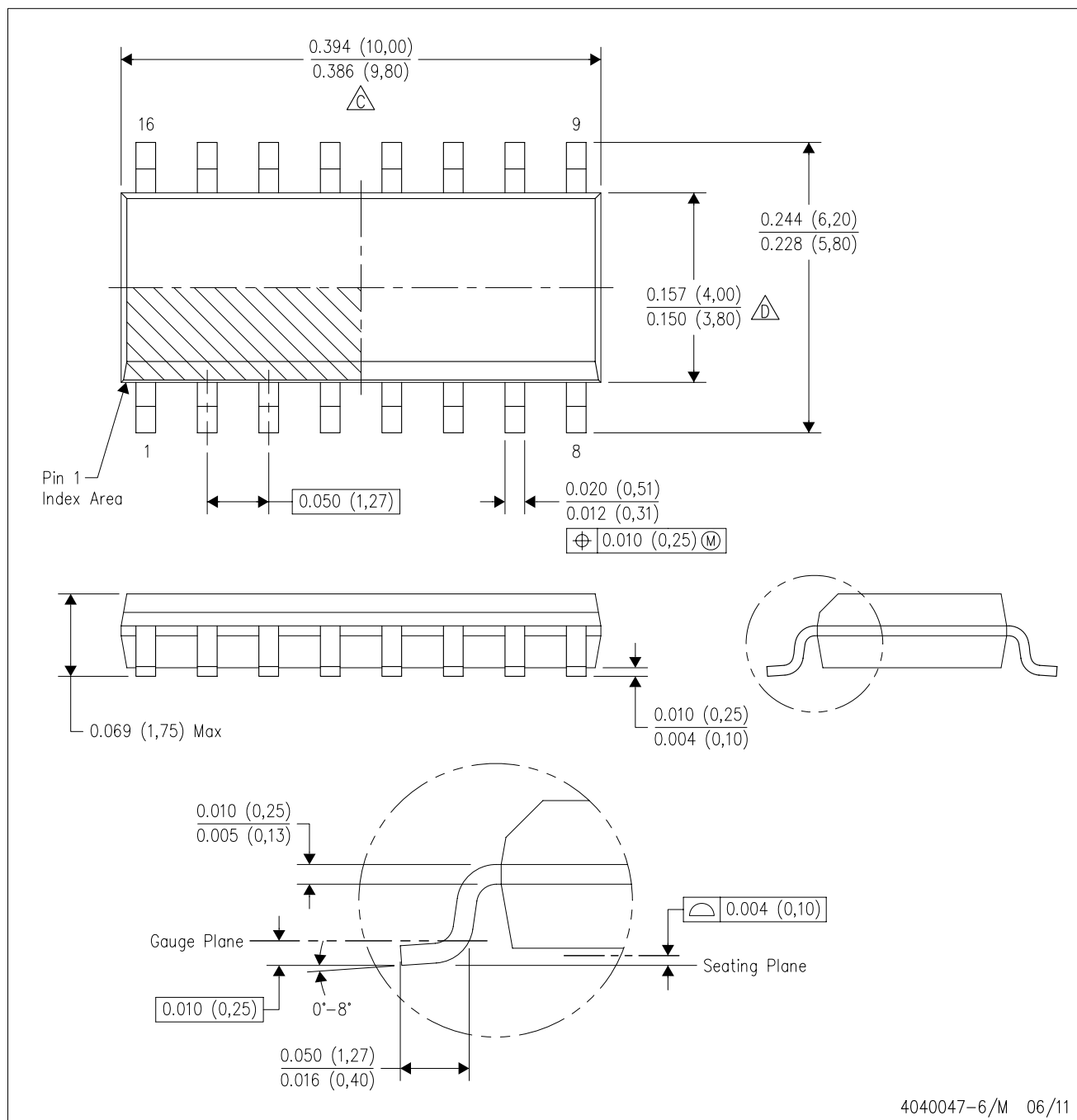
TUBE


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
CD74HC259E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC259E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC259E.A	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC259E.A	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E.A	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E.A	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259EE4	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259EE4	N	PDIP	16	25	506	13.97	11230	4.32

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE

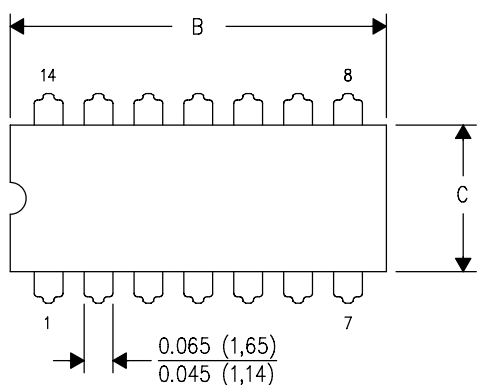


- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - $\triangle C$ Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - $\triangle D$ Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AC.

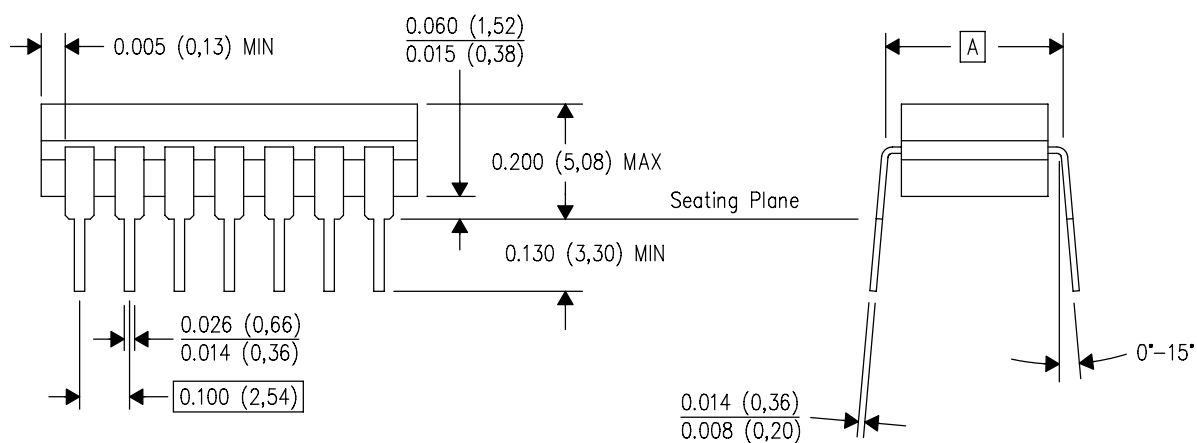
J (R-GDIP-T**)

14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)



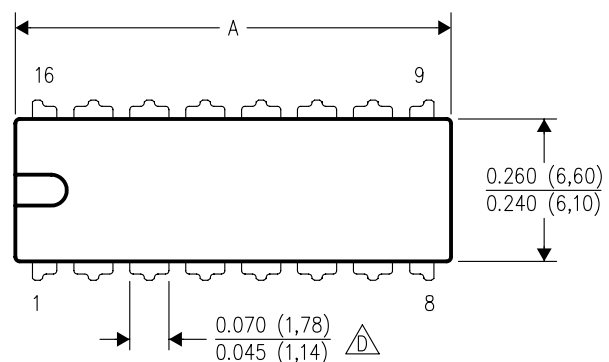
4040083/F 03/03

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package is hermetically sealed with a ceramic lid using glass frit.
 - D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
 - E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

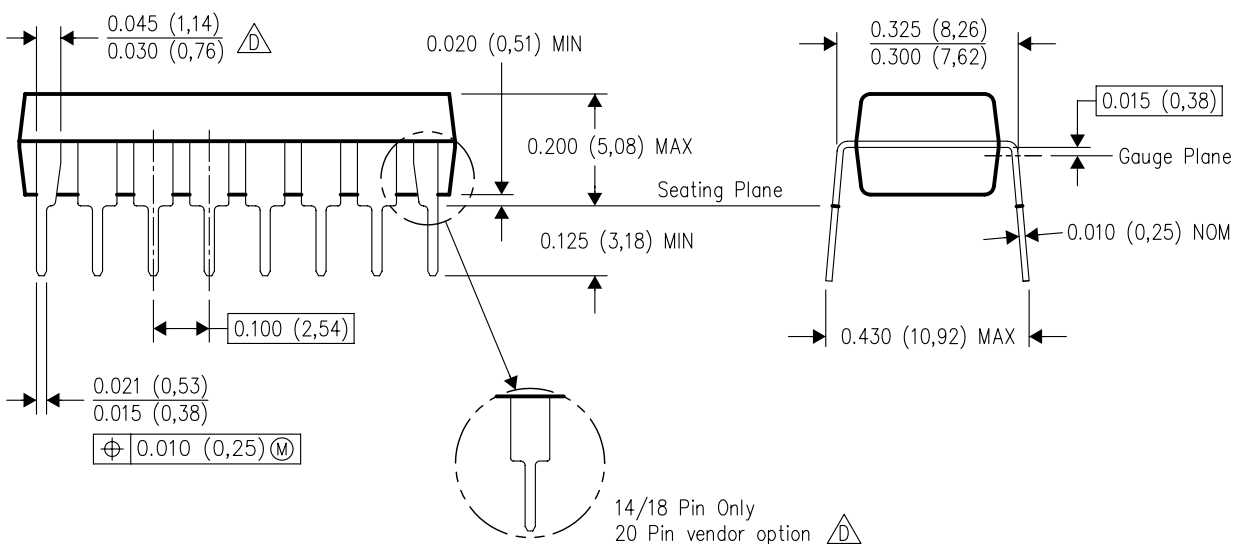
N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



4040049/E 12/2002

NOTES:

- A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
-  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 The 20 pin end lead shoulder width is a vendor option, either half or full width.

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